Product data sheet

1. General description

WG75N120MFP1 uses advanced Fine Trench Field-stop IGBT technology with anti-parallel diode in TO-247-Plus package to provide extremely low Vce(sat), and excellent switching performance. This device offers Best-in-Class efficiency in hard switching and resonant topology.





2. Features and benefits

- · Maximum junction temperature 175 °C
- · Smooth & Optimized switching
- · Positive Temperature efficient for Easy Parallel Operating
- · Very soft, fast recovery anti-parallel diode
- · EMI Improved Design

3. Applications

- Motor control
- PFC
- UPS
- Resonant converters
- · Mid to high switching frequency applications

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter		Notes		Value		Unit
V _{CE}	Collector-emitter voltage, T _j ≥ 25 °C				1200		V
I _C	DC collector current, limited by $T_{j(max)}$ $T_{c} = 100~^{\circ}C$				75		Α
Symbol	Parameter Conditions		Notes	Min	Тур	Max	Unit
Static cha	Static characteristics						
V _{CE(sat)}	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}; I_{C} = 75 \text{ A}; T_{j} = 25 \text{ °C}$		-	1.55	2.05	V

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		•C
2	С	collector		
3	E	emitter		
mb	С	mounting base; connected to collector	1 2 3	G E sym200

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WG75N120MFP1	TO247P	WG75N120MFP1Q	Tube	30	TO247PA	09-Apr-2025

7. Marking

Table 4. Marking codes

Type number	Marking codes
WG75N120MFP1	75N120MF

IGRT

8. Limiting values

Table 5. Limiting values

Symbol	Parameter	Notes	Value	Unit
V _{CE}	Collector-emitter voltage, T _j ≥ 25 °C		1200	V
I _c	DC collector current, limited by $T_{j(max)}$ $T_c = 25 ^{\circ}\text{C}$ $T_c = 100 ^{\circ}\text{C}$		150 75	А
I _{C(puls)}	Pulsed collector current, t _p limited by T _{j(max)}		225	Α
-	Turn off safe operating area $V_{CE} \le 1200 \text{ V}, T_j \le 175 ^{\circ}\text{C}, t_p = 1 \mu\text{s}$		225	А
I _F	Diode forward current, limited by $T_{j(max)}$ T_{c} = 25 °C T_{c} = 100 °C		150 75	А
I _{Fpuls}	Diode pulsed current, t _p limited by T _{j(max)}		225	Α
V_{GE}	Gate-emitter voltage		±20	V
P _{tot}	Power dissipation $T_C = 25 ^{\circ}\text{C}$ Power dissipation $T_C = 100 ^{\circ}\text{C}$		1071 536	W
tsc	Short circuit withstand time VGE = 15.0 V, VCC ≤ 600 V Allowed number of short circuits < 1000 Time between short circuits: ≥ 1.0 s Tj = 175°C		10	μs
T _{stg}	Storage temperature		-55 to +150	°C
T _{jmax}	Maximum operating junction temperature		175	°C
-	Peak soldering temperture		260	°C
М	Mounting Torque with washer		0.55	Nm

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R _{th(j-c)}	IGBT thermal resistance from junction to case			-	0.14	-	K/W
R _{th(j-c)}	Diode thermal resistance from junction to case			-	0.45	-	K/W
R _{th(j-a)}	thermal resistance from junction to ambient			-	40	-	K/W

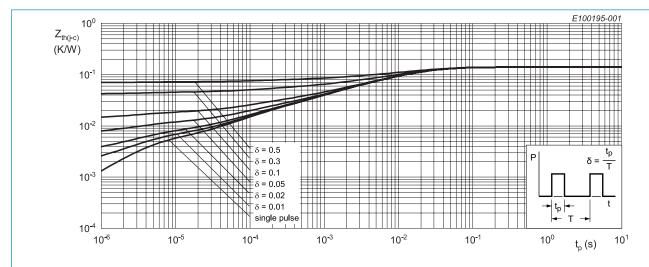


Fig. 1. Transient thermal impedance from junction to case as a function of pulse duration; IGBT

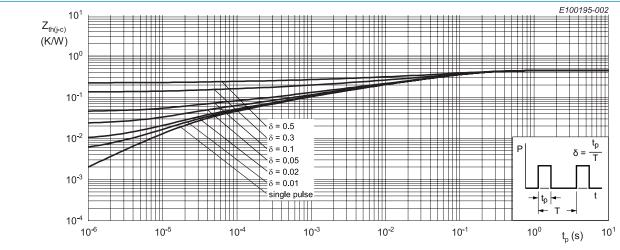


Fig. 2. Transient thermal impedance from junction to case as a function of pulse duration; Diode

IGRT

10. Characteristics

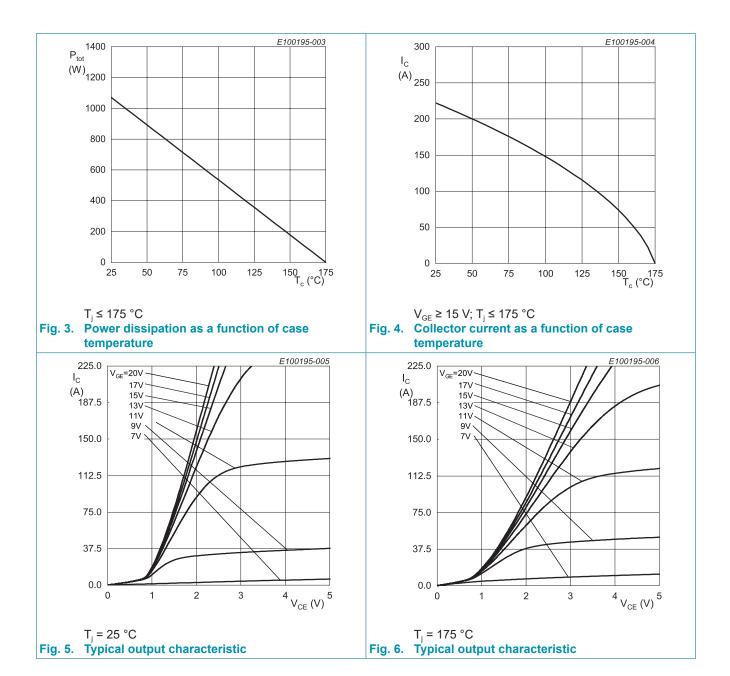
Table 7. Characteristics

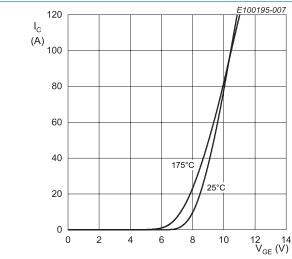
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
BV _{CES}	Collector-emitter breakdown voltage	$V_{GE} = 0 \text{ V}; I_{C} = 1.0 \text{ mA}$		1200	-	-	V
$V_{\text{CE(sat)}}$	Collector-emitter saturation	$V_{GE} = 15 \text{ V}; I_{C} = 75 \text{ A}; T_{j} = 25 \text{ °C}$		-	1.55	2.05	V
	voltage	V _{GE} = 15 V; I _C = 75 A; T _j = 175 °C		-	1.95	-	V
V_{F}	Diode forward voltage	$V_{GE} = 0 \text{ V}; I_F = 75 \text{ A}; T_j = 25 \text{ °C}$		-	2.4	-	V
		$V_{GE} = 0 \text{ V}; I_F = 75 \text{ A}; T_j = 175 \text{ °C}$		-	2.2	-	V
$V_{\text{GE(th)}}$	Gate-emitter threhold voltage	$I_{\rm C}$ = 0.5 mA; $V_{\rm CE}$ = $V_{\rm GE}$		4.6	5.7	6.8	V
Zero gate voltage of current	Zero gate voltage collector	V_{CE} = 1200 V; V_{GE} = 0 V; T_{j} = 25 °C		-	-	500	μΑ
	current	$V_{CE} = 1200 \text{ V}; V_{GE} = 0 \text{ V};$ $T_j = 175 \text{ °C}$		-	-	10	mA
g _{fs}	Transconductance	$V_{CE} = 20 \text{ V}; I_{C} = 75 \text{ A}$		-	46	-	S
Dynamic	characteristics						
C _{ies}	Input capacitance	$V_{CE} = 30 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz};$		-	4715	-	pF
C _{oes}	Output capacitance	$T_j = 25 ^{\circ}\text{C}$		-	181	-	pF
C _{res}	Reverse transfer capacitance			-	36	-	pF
Q_{G}	Gate charge	V_{CC} = 960 V; I_{C} = 75 A; V_{GE} = 15 V; T_{i} = 25 °C		-	203	-	nC

11. Switching Characteristics

Table 8. Switching Characteristics, Inductive Load

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
IGBT cha	racteristics						
$t_{d(on)}$	Turn-on delay time	T _j = 25 °C;		-	60	-	nS
t _r	Rise time	$V_{CC} = 600 \text{ V}; I_C = 75 \text{ A};$ $V_{GE} = 15 \text{ V} / 0 \text{ V};$		-	78	-	nS
$t_{\text{d(off)}}$	Turn-off delay time	$R_G = 10 \Omega$		-	268	-	nS
t _f	Fall time			-	126	-	nS
E _{on}	Turn-on energy			-	6.2	-	mJ
E _{off}	Turn-off energy			-	4	-	mJ
E _{ts}	Total switching energy			-	10.2	-	mJ
t _{d(on)}	Turn-on delay time	T _j = 175 °C;		-	57	-	nS
t _r	Rise time	$V_{CC} = 600 \text{ V}; I_C = 75 \text{ A};$ $V_{GE} = 15 \text{V} / 0 \text{V};$		-	73	-	nS
$t_{d(off)}$	Turn-off delay time	$R_G = 10 \Omega$		-	306	-	nS
t _f	Fall time			-	218	-	nS
E _{on}	Turn-on energy			-	9.1	-	mJ
E _{off}	Turn-off energy			-	5.8	-	mJ
E _{ts}	Total switching energy			-	14.9	-	mJ
Diode cha	aracteristics		1			1	
t _{rr}	Reverse recovery time	T _j = 25 °C;		-	153	-	nS
Q _r	Reverse recovery charge	$V_R = 600 \text{ V}; I_F = 75 \text{ A};$ $dI_F/dt = 850 \text{A/us}$		-	2370	-	nC
I _{RM}	Reverse recovery peak current	300.035		-	31	-	А
t _{rr}	Reverse recovery time	T _j = 175 °C;		-	362	-	nS
Q _r	Reverse recovery charge	$V_R = 600 \text{ V}; I_F = 75 \text{ A};$ $dI_F/dt = 850 \text{A/us}$		-	7960	-	nC
I _{RM}	Reverse recovery peak current	-		-	45	-	А

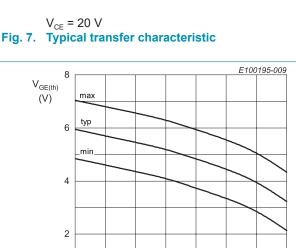




0

0

25



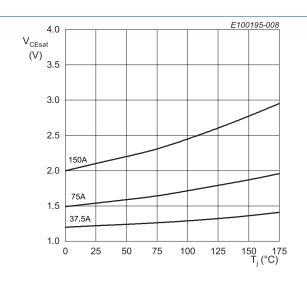
 $I_{c} = 500 \, \mu A$ Fig. 9. Gate-emitter threshold voltage as a function of junction temperature

75

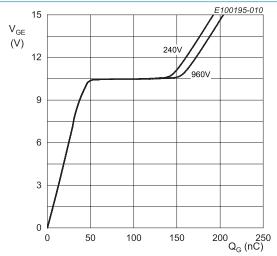
100

125

50

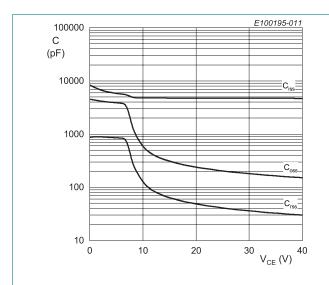


 $V_{GE} = 15 \text{ V}$ Fig. 8. Typical collector-emitter saturation voltage as a function of junction temperature



 $I_{c} = 75 A$ Fig. 10. Typical gate charge

150 175 T_j (°C)



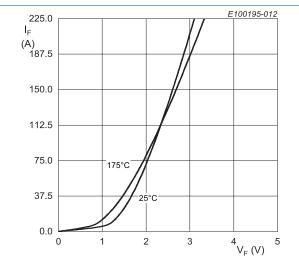
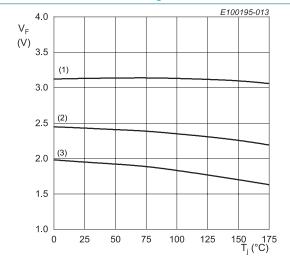
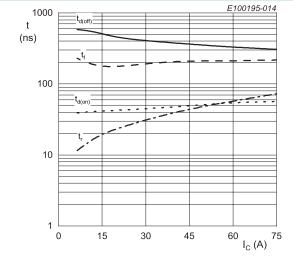


Fig. 12. Typical diode forward current as a function of forward voltage

 $\label{eq:VGE} V_{GE} = 0 \ V; \ f = 1 \ MHz$ Fig. 11. Typical capacitance as a function of collector-emitter voltage





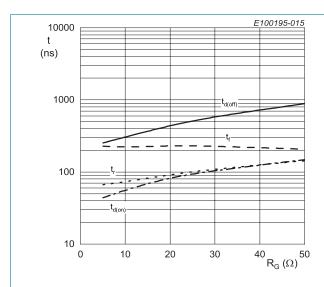
(1) $I_F = 150 A$ (2) $I_F = 75 A$

(3) $I_F = 37.5 A$

 R_{g} = 10 $\Omega;$ V_{GE} = 15V/0V; T_{j} = 175 °C; V_{CE} = 600 V; inductive load

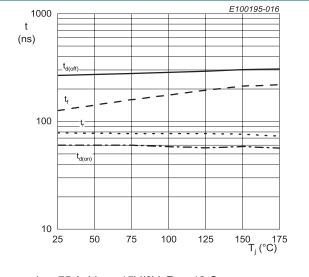
Fig. 13. Typical diode forward voltage as a function of junction temperature

Fig. 14. Typical switching times as a function of collector current



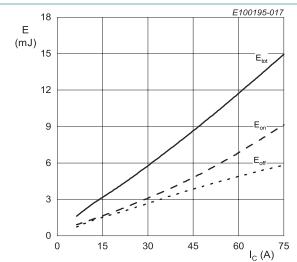
 I_C = 75 A; V_{GE} = 15V/0V; T_j = 175 °C; V_{CE} = 600 V; inductive load

Fig. 15. Typical switching times as a function of gate resistance



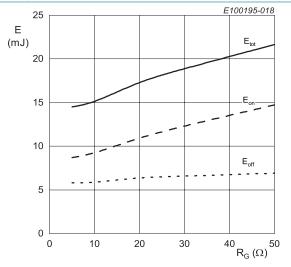
 I_{C} = 75 A; V_{GE} = 15V/0V; R_{g} = 10 Ω ; V_{CE} = 600 V; inductive load

Fig. 16. Typical switching times as a function of junction temperature



 R_g = 10 Ω ; V_{GE} = 15V/0V; T_j = 175 °C; V_{CE} = 600 V; inductive load

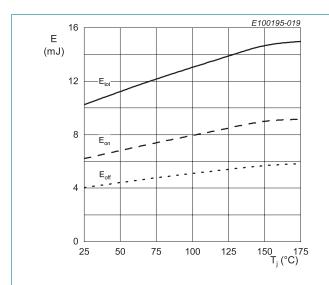
Fig. 17. Typical switching energy losses as a function of collector current

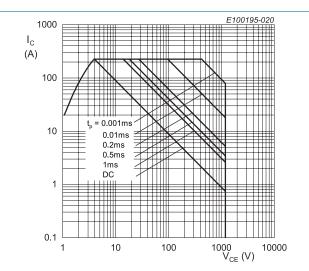


 I_{C} = 75 A; V_{GE} = 15V/0V; T_{j} = 175 °C; V_{CE} = 600 V; inductive load

Fig. 18. Typical switching energy losses as a function of gate resistance

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 I_{C} = 75 A; V_{GE} = 15V/0V; R_{g} = 10 $\Omega;$ V_{CE} = 600 V; inductive load

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Fig. 20. Forward bias safe operating area

Fig. 19. Typical switching energy losses as a function of junction temperature

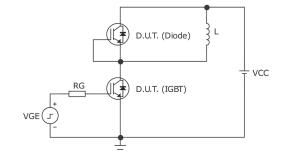


Fig. 21. Test circuit for inductive load switching

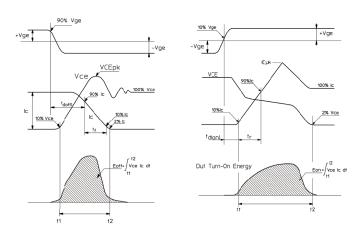
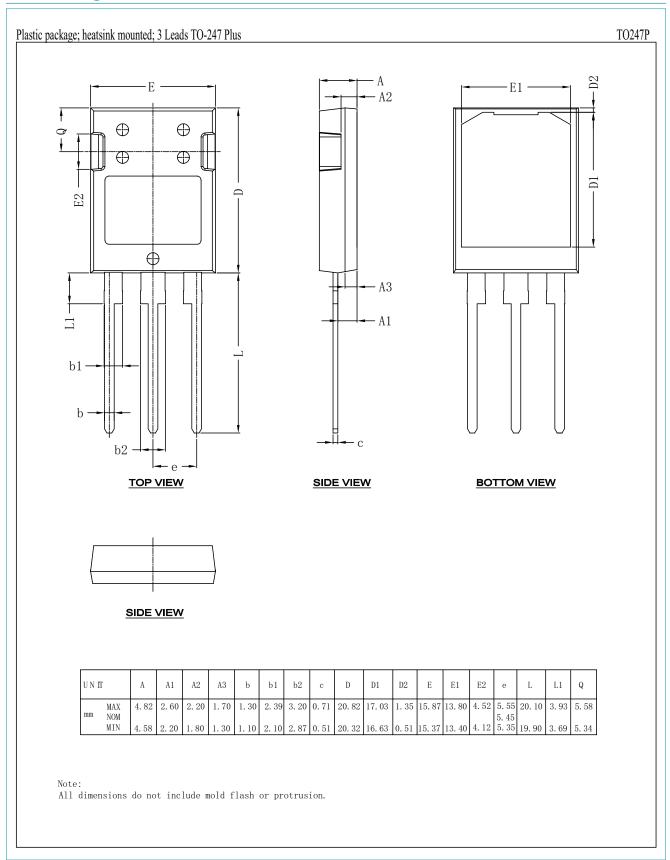


Fig. 22. Definition of switching times and losses

12. Package outline



13. Legal information

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Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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